

Device Modeling Report

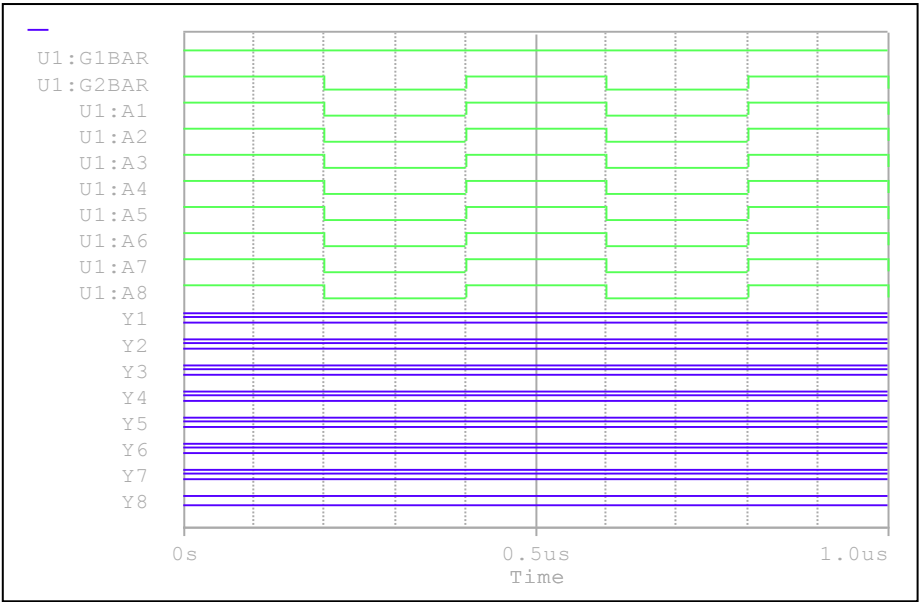
COMPONENTS : CMOS DIGITAL INTEGRATED CIRCUIT
PART NUMBER : TC74VHC540F
MANUFACTURER : TOSHIBA



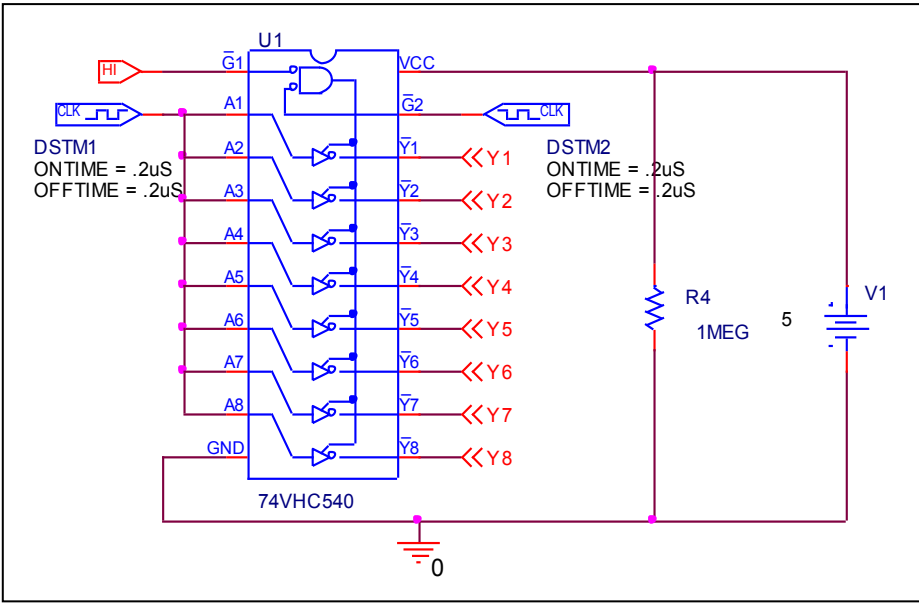
Bee Technologies Inc.

Truth Table

Circuit simulation result



Evaluation circuit

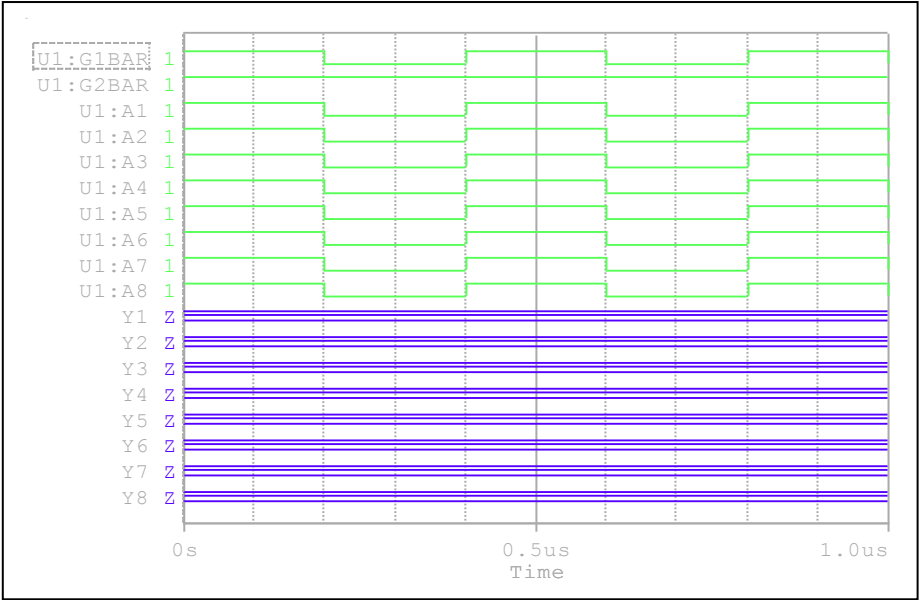


Comparison table

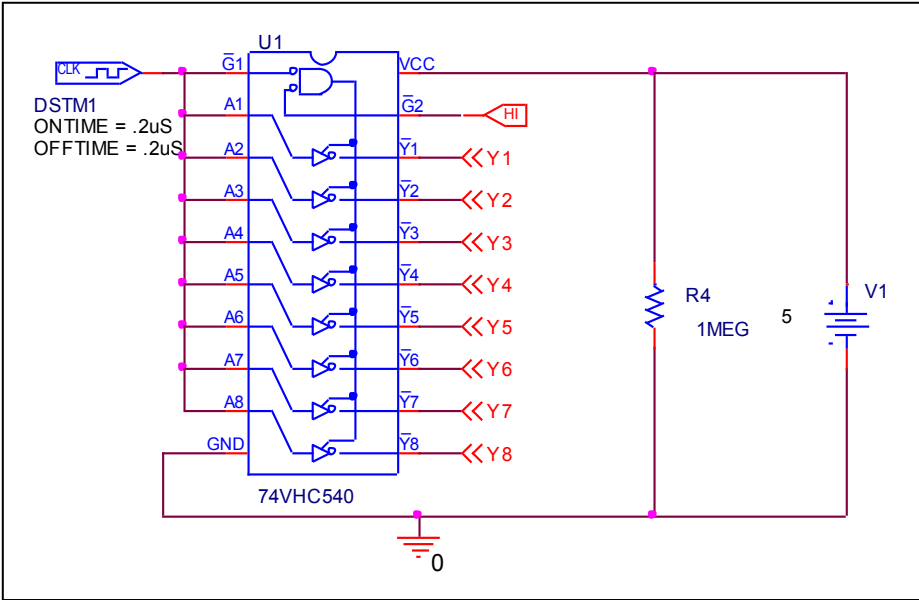
Input			Output		%Error
G1	G2	An	Yn (Measurement)	Yn (Simulation)	
H	X	X	Z	Z	0

Truth Table

Circuit simulation result



Evaluation circuit

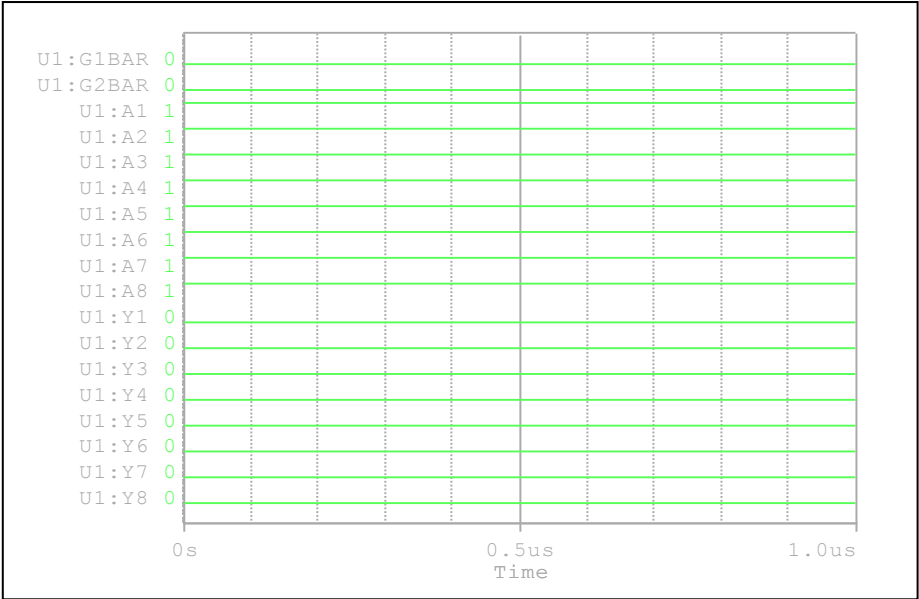


Comparison table

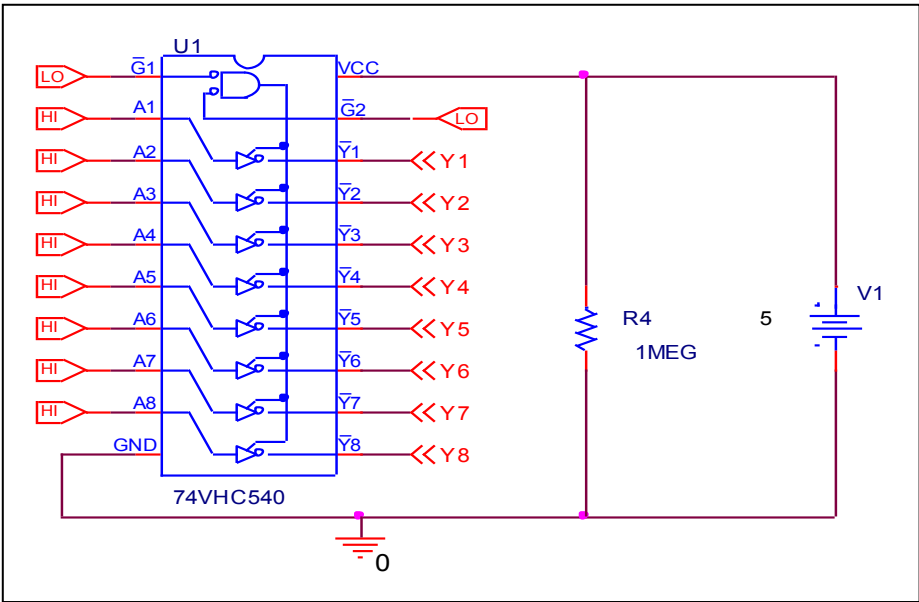
Input			Output		%Error
G1	G2	An	Yn (Measurement)	Yn (Simulation)	
X	H	X	Z	Z	0

Truth Table

Circuit simulation result



Evaluation circuit

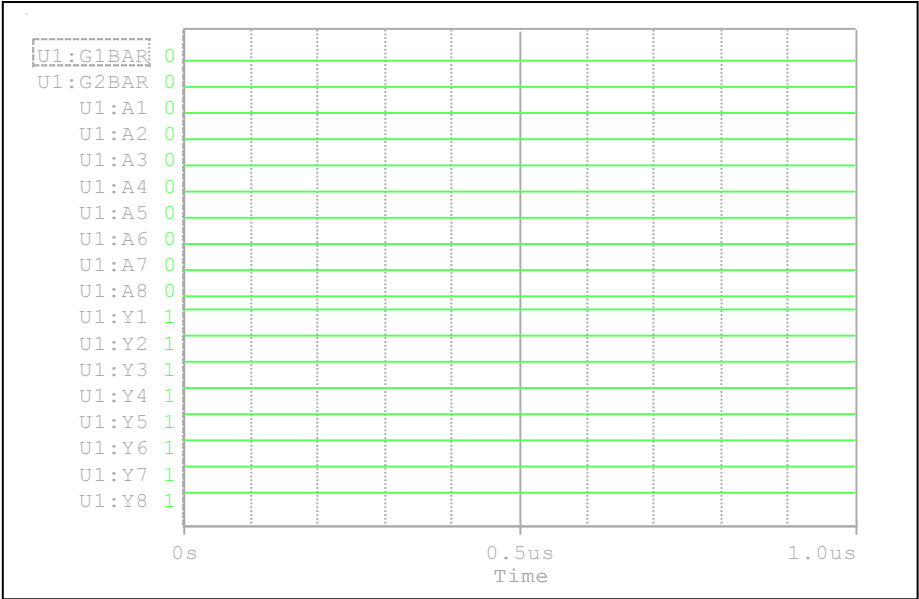


Comparison table

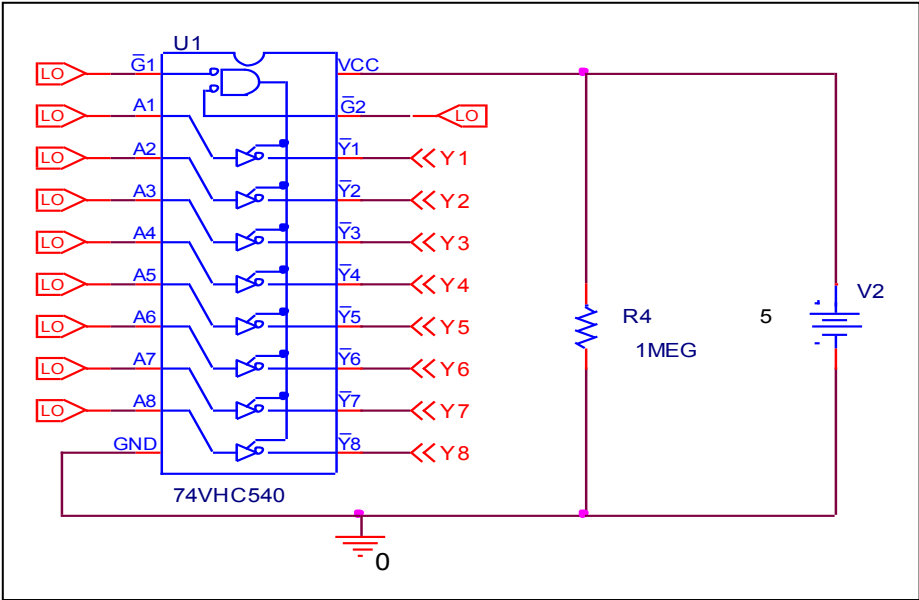
Input			Output		%Error
G1	G2	An	Yn (Measurement)	Yn (Simulation)	
L	L	H	L	L	0

Truth Table

Circuit simulation result



Evaluation circuit

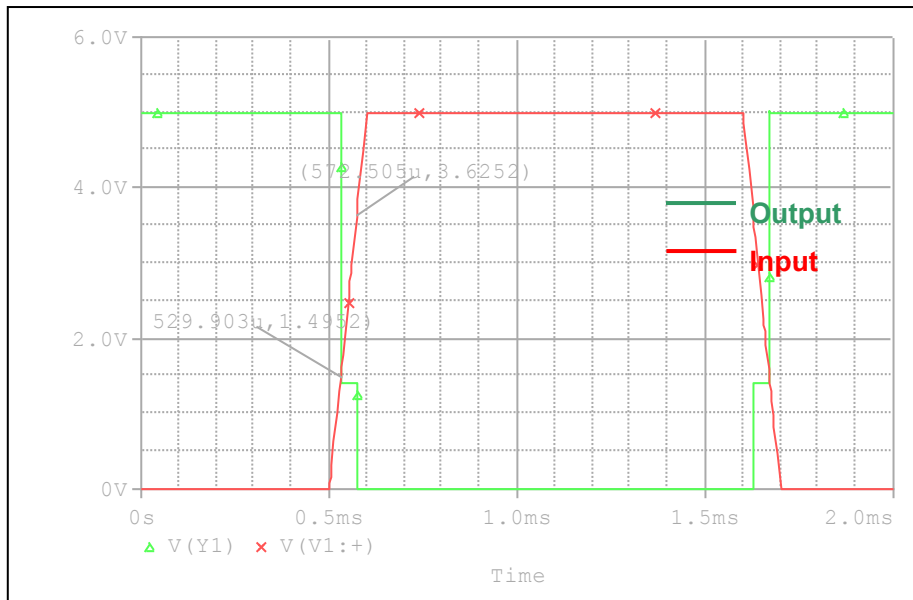


Comparison table

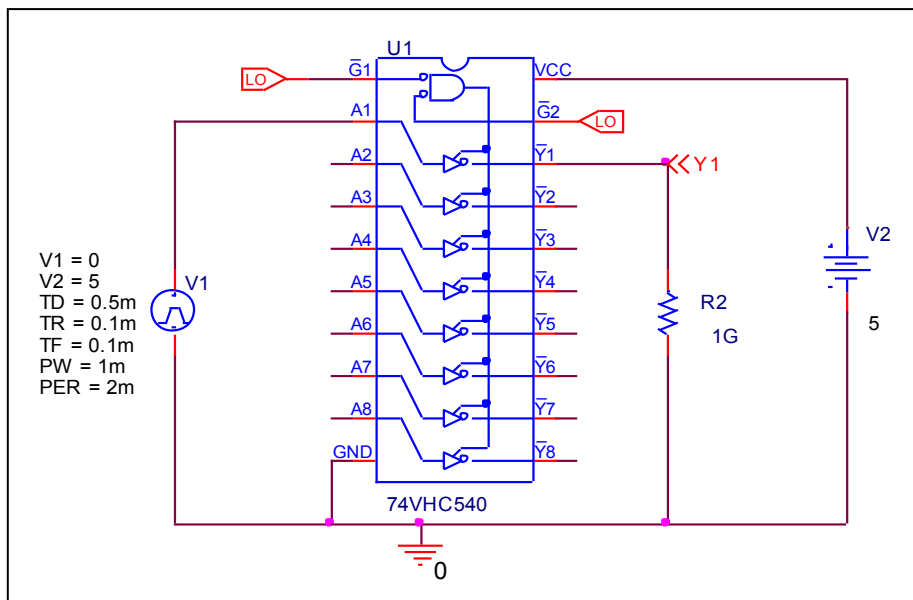
Input			Output		%Error
G1	G2	An	Yn (Measurement)	Yn (Simulation)	
L	L	L	H	H	0

High Level and Low Level Input Voltage

Circuit simulation result



Evaluation circuit

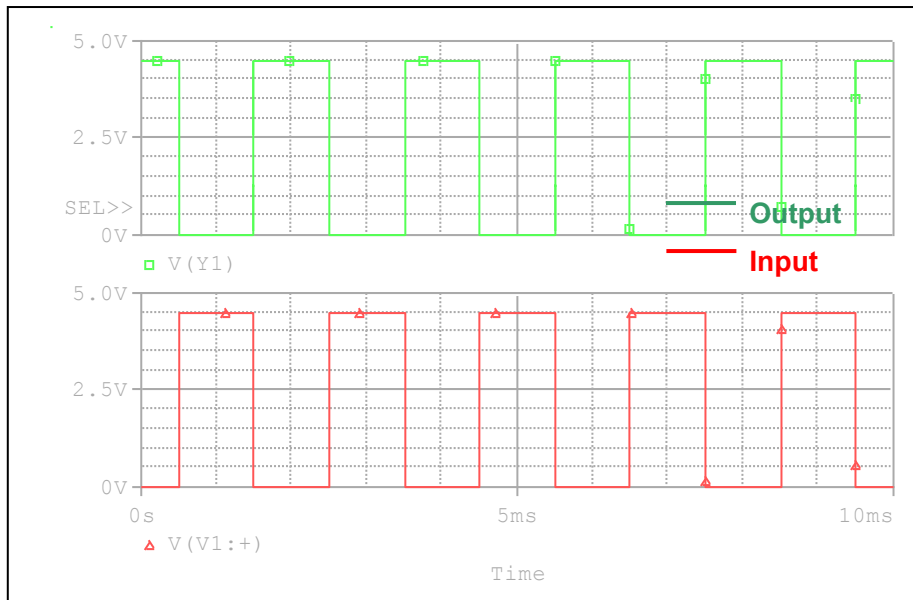


Comparison table

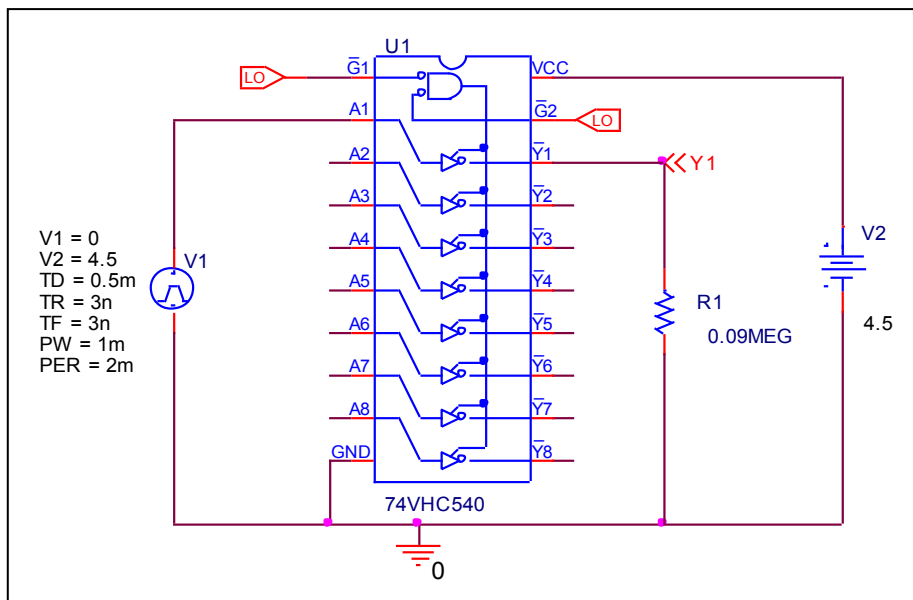
$V_{CC} = 5V$	Measurement	Simulation	%Error
Min $V_{IH} = (V_{CC} \cdot 0.7)$ (V)	3.5	3.6252	3.577
Min $V_{IL} = (V_{CC} \cdot 0.3)$ (V)	1.5	1.4952	-0.320

High Level and Low Level Output Voltage

Circuit simulation result



Evaluation circuit

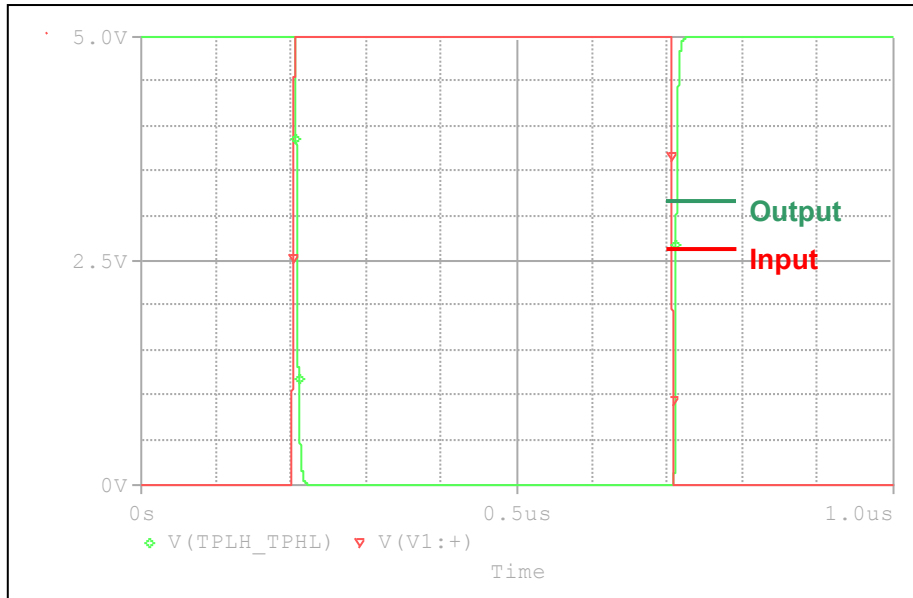


Comparison table

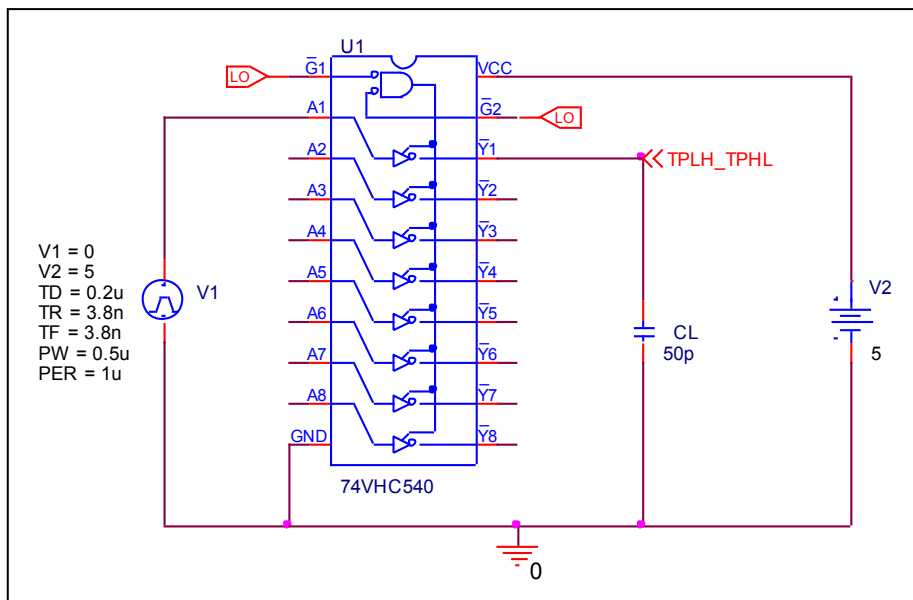
$V_{CC} = 4.5V$	Measurement	Simulation	%Error
$V_{OH} (V)$	4.5	4.4978	-0.049
$V_{OL} (V)$	0	0	0

Propagation Delay Time

Circuit simulation result



Evaluation circuit

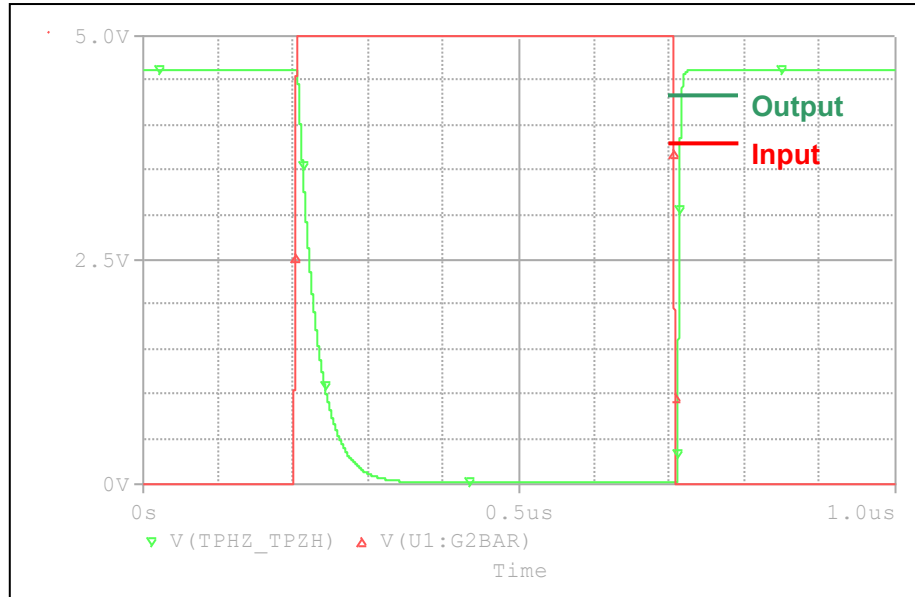


Comparison table $C_L = 50 \text{ pF}$

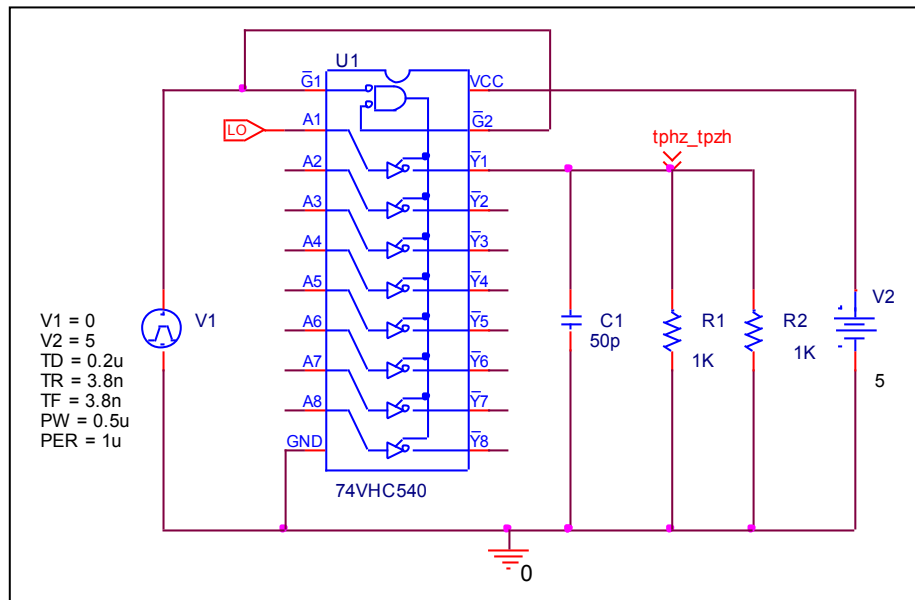
$V_{CC} = 5 \text{ V}$, $t_r = t_f = 3 \text{ ns}$	Measurement	Simulation	%Error
$t_{pLH} \text{ (ns)}$	5.2	5.2479	0.921
$t_{pHL} \text{ (ns)}$	5.2	5.2837	1.610

Output enable time, high impedance (off) to high output (t_{PZH})
Output disable time, high to high impedance (off) output (t_{PHZ})

Circuit simulation result



Evaluation circuit

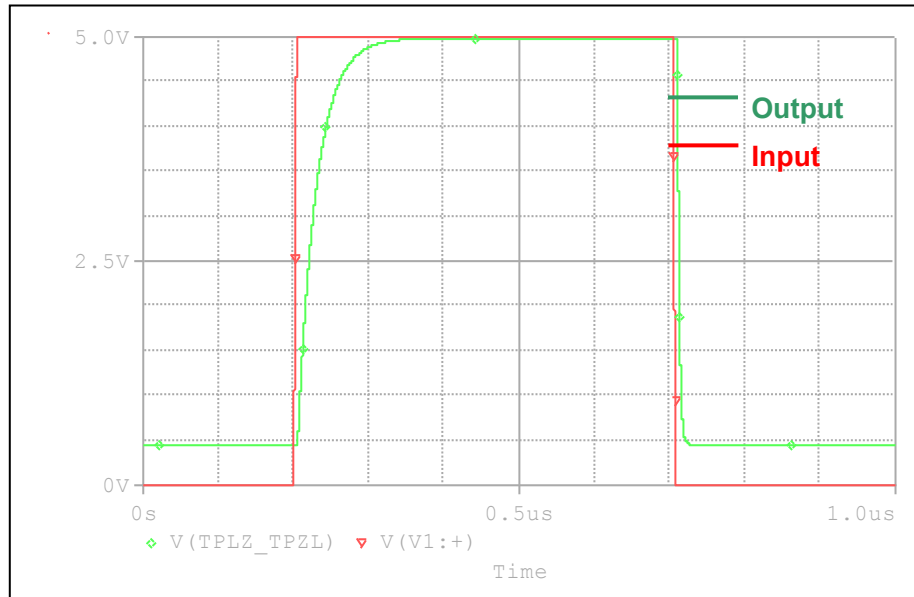


Comparison table $C_L = 50 \text{ pF}$, $R_L = 1 \text{ K}\Omega$

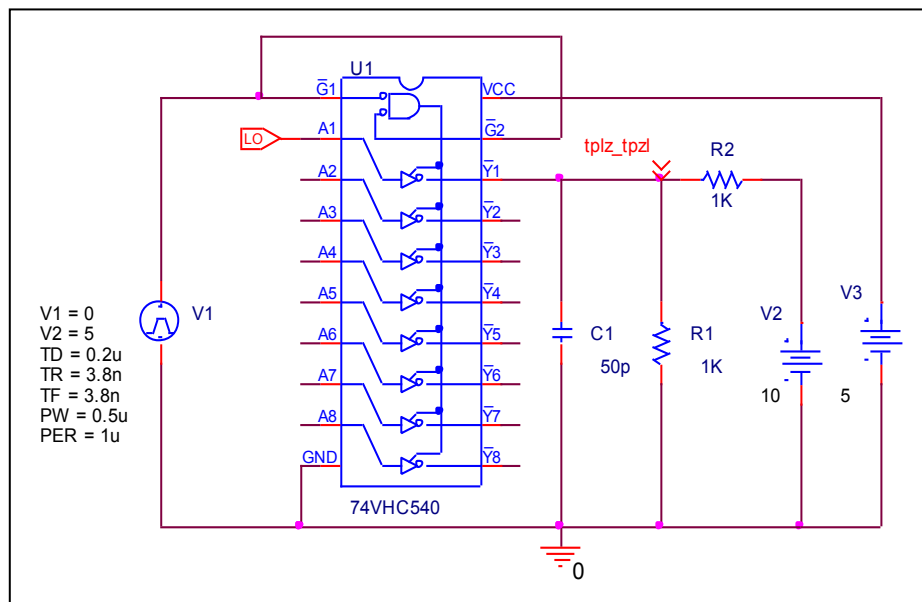
$V_{CC} = 5 \text{ V}$, $t_r = t_f = 3 \text{ ns}$	Measurement	Simulation	%Error
$t_{PHZ} \text{ (ns)}$	6	6.0537	0.895
$t_{pZH} \text{ (ns)}$	6.2	6.2423	0.682

Output enable time, high impedance (off) to low output (t_{PZL})
Output disable time, low to high impedance (off) output (t_{PLZ})

Circuit simulation result



Evaluation circuit



Comparison table $C_L = 50 \text{ pF}$, $R_L = 1 \text{ K}\Omega$

$V_{CC} = 5 \text{ V}$, $t_r = t_f = 3 \text{ ns}$	Measurement	Simulation	%Error
$t_{PLZ} \text{ (ns)}$	6	6.0557	0.928
$t_{pZL} \text{ (ns)}$	6.2	6.2378	0.610